

Diffraction Effects on Broadband Radiation in Multi-staged Systems

Eric L. Shirley

*Sensor Science Division, National Institute of Standards and Technology
Gaithersburg, Maryland*

Motivation: To better understand diffraction, towards useful approximations to reduce computational requirements (risk reduction)

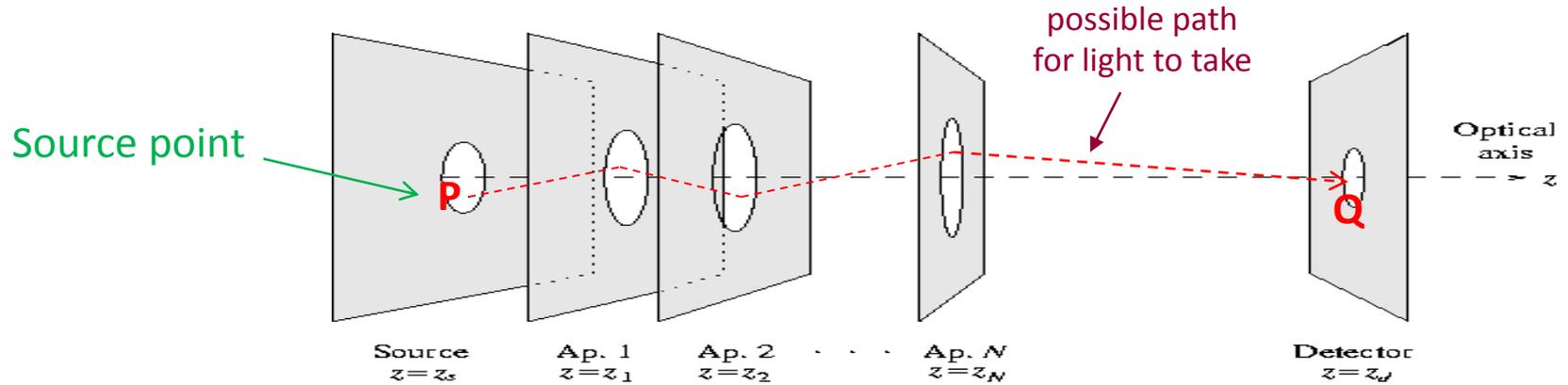
Outline:

- Review very basic diffraction theory
- Decomposing systems into source-aperture-detector (SAD) subsystems
- Beyond the SAD problem: itemizing higher-order effects
- On spectral and thermal aspects of diffraction for broadband radiation
- Higher-order effects in practice
- Conclusions



“Master Problem”: end-to-end propagation of light in optical systems

- paraxial, scalar gaussian optics
- unfolded optical systems
- reflective optics treated as lenses/apertures



$$u(\mathbf{Q}) = \frac{U_0}{(i\lambda)^N} \int_{A_1} d\mathbf{x}_1 \dots \int_{A_k} d\mathbf{x}_k \dots \int_{A_N} d\mathbf{x}_N \underbrace{e^{iq\sum \delta_i(\mathbf{x}_i)} G(\mathbf{P}, \mathbf{x}_1) \dots G(\mathbf{x}_N, \mathbf{Q})}_{F(\mathbf{P}, \mathbf{Q}, \{\mathbf{x}_k\})}$$

Light field

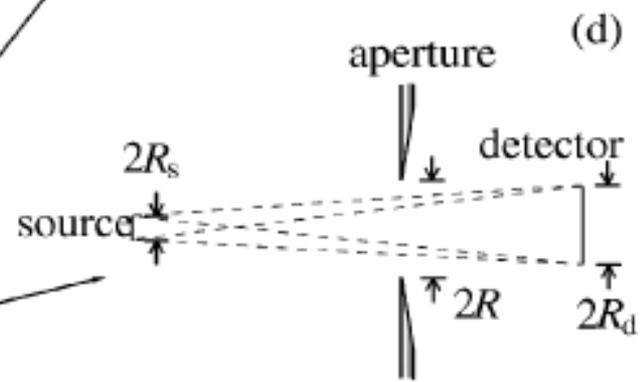
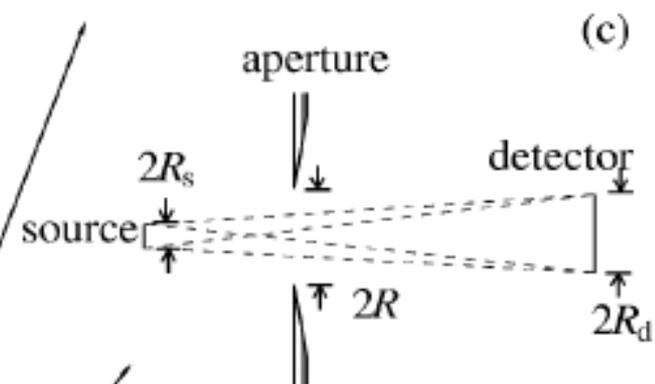
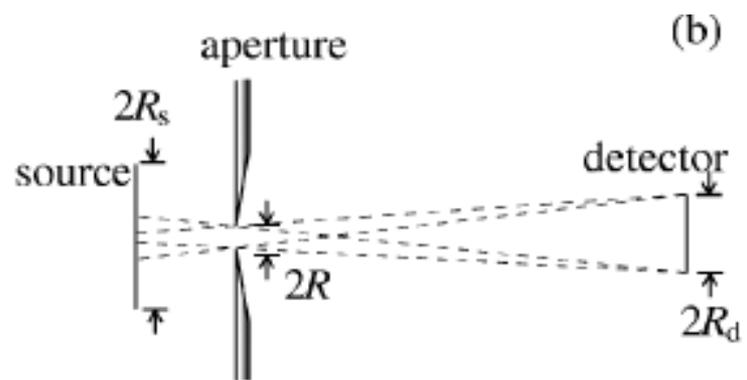
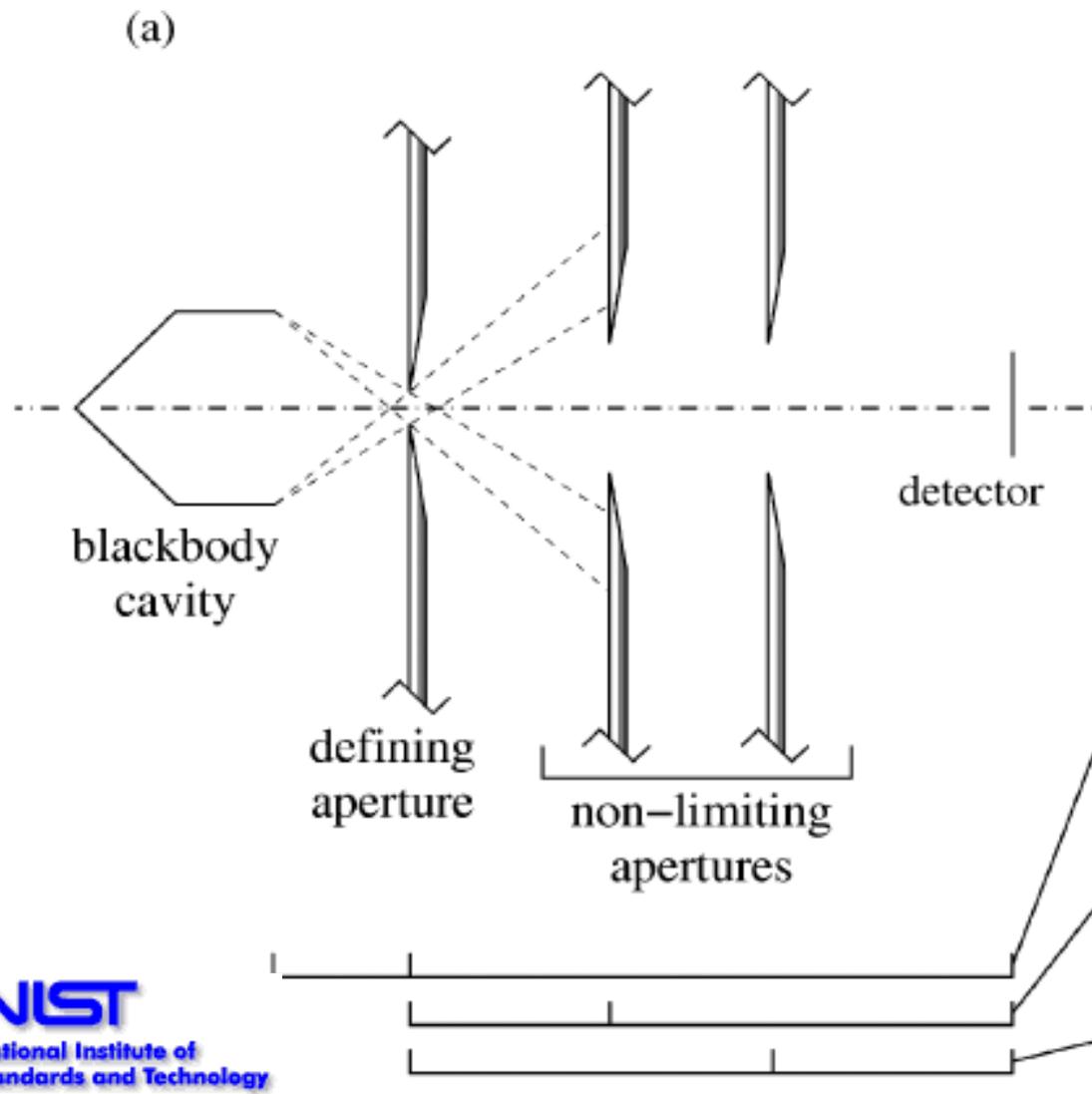
Focusing effects

Free-space propagator

$$G(\mathbf{x}, \mathbf{x}') = \frac{1}{|z' - z|} \exp \left[iq \left(|z' - z| + \frac{(x' - x)^2 + (y' - y)^2}{2|z' - z|} \right) \right]$$

Multi-staged vs. single-staged systems

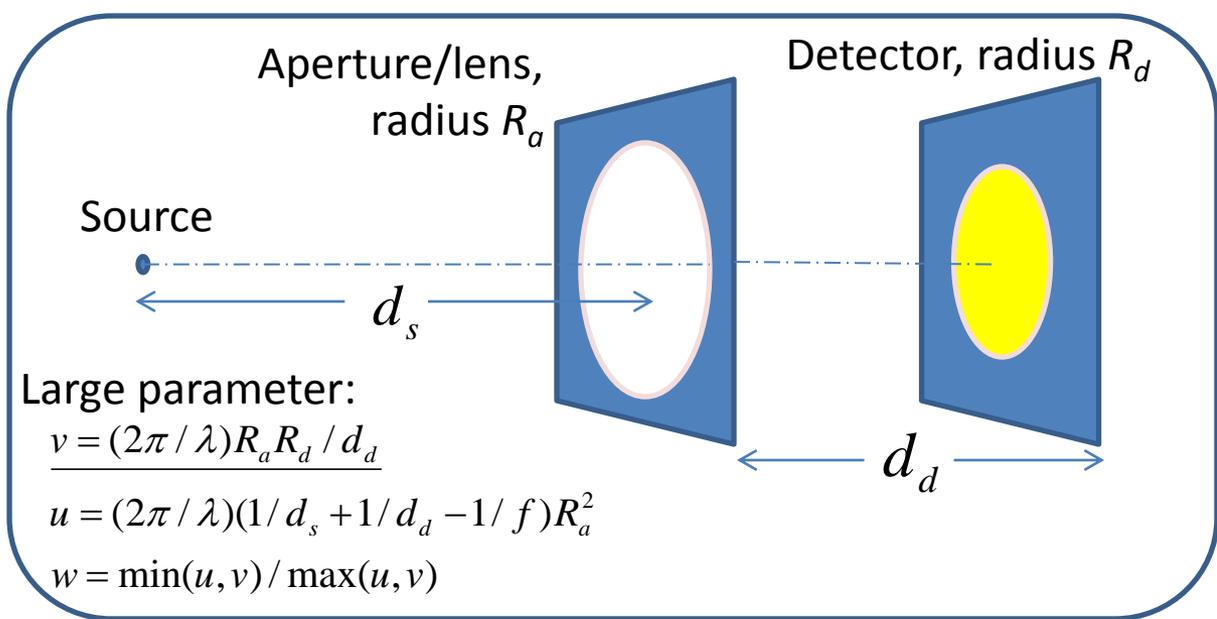
- Break system down into 1-aperture subsystems
- Non-additivity of effects of subsystems to make total effect



Diffraction effects at

1st order:

- Monochromatic light, point source
- Formula for flux on aperture reaching detector = Φ_d / Φ_a



Bkg: JOSA A 21, 1895 (2004)

$$\Phi_d / \Phi_a = L(u, v) = w^2 [1 + L_B(v, w)] - L_X(v, w)$$

or

$$\Phi_d / \Phi_a = L(u, v) = 1 - L_B(v, w)$$

$$L_B(v, w) = \frac{2}{\pi v(1-w^2)} - \frac{1}{\pi v^2(1-w^2)} \cos(2v) + \frac{w^8 - 20w^6 - 90w^4 - 20w^2 + 1}{4\pi v^3(1-w^2)^5} - \frac{w^4 - 18w^2 + 1}{4\pi v^3(1-w^2)^3} \sin(2v) + \dots$$

$$L_X(v, w) = (4w/v) [Y_1(v/w, v) \cos(2v(w+1/w)) + Y_2(v/w, v) \sin(2v(w+1/w))]$$

$$Y_1(v, w) = + \frac{vw[2/(\pi v)]^{1/2}}{2} \left[\frac{\sin(v - \pi/4)}{v} S_1^{(1)} + \frac{\cos(v - \pi/4)}{v^2} C_2^{(1)} + \frac{\sin(v - \pi/4)}{v^3} S_3^{(1)} + \dots \right]$$

$$Y_2(v, w) = - \frac{v[2/(\pi v)]^{1/2}}{2} \left[\frac{\sin(v + \pi/4)}{v} S_1^{(2)} + \frac{\cos(v + \pi/4)}{v^2} C_2^{(2)} + \frac{\sin(v + \pi/4)}{v^3} S_3^{(2)} + \dots \right],$$

$$S_1^{(1)} = \frac{2(w^2 + 1)}{(1 - w^2)^2}$$

$$S_1^{(2)} = \frac{4w^2}{(1 - w^2)^2}$$

$$C_2^{(1)} = \frac{3(w^6 + 31w^4 + 31w^2 + 1)}{4(1 - w^2)^4}$$

$$C_2^{(2)} = \frac{3(5w^6 + 22w^4 + 5w^2)}{2(1 - w^2)^4}$$

$$S_3^{(1)} = \frac{15(w^{10} - 195w^8 - 1854w^6 - 1854w^4 - 195w^2 + 1)}{64(1 - w^2)^6}$$

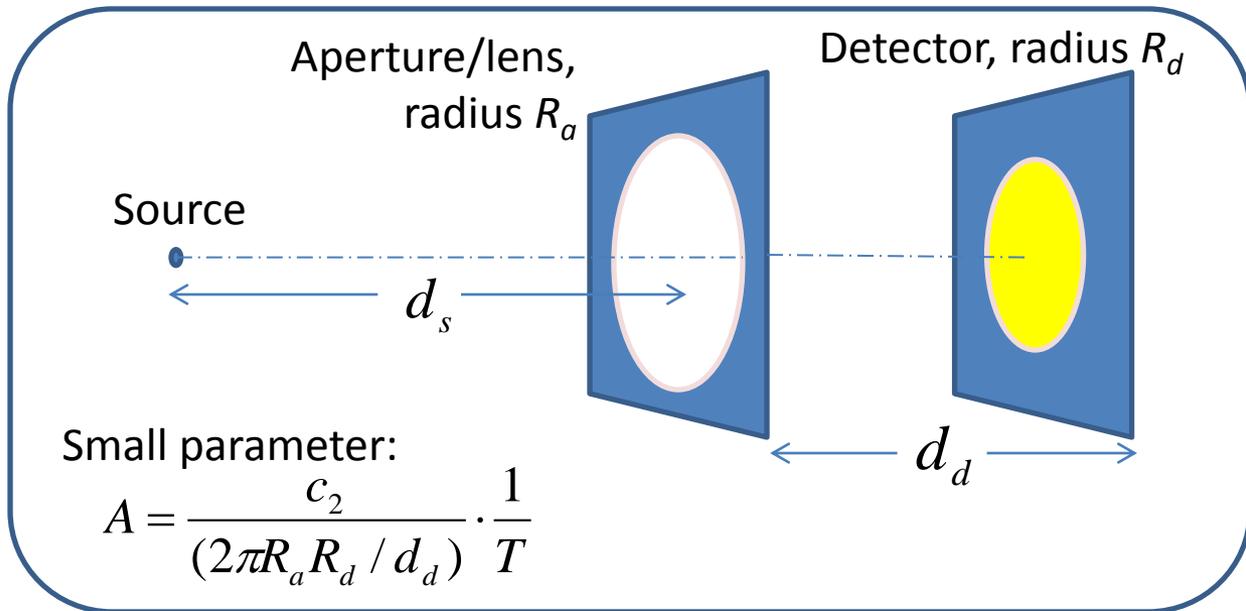
$$S_3^{(2)} = \frac{15(-7w^{10} - 420w^8 - 1194w^6 - 420w^4 - 7w^2)}{32(1 - w^2)^6}$$

Diffraction effects at

1st order:

- Blackbody radiation
- Point source
- Integration over Planck function replaces L_B, L_X with F_B, F_X

Bkg: JOSA A 21, 1895 (2004)



$$\Phi_d / \Phi_a = w^2 + \left(\frac{w^2 A^4}{6\zeta(4)} \right) F_B(A, w) - \left(\frac{A^4}{6\zeta(4)} \right) F_X(A, w)$$

or

$$\Phi_d / \Phi_a = 1 - \left(\frac{A^4}{6\zeta(4)} \right) F_B(A, w)$$

$$F_B(A, w) \sim \sum_{p=-3}^{\infty} (C_p A^p + L_p A^p \log_e A);$$

$$F_X(A, w) \sim - \frac{96w^6(1+3w^2+w^4)}{(1-w^2)^7}$$

$$C_{-3} = \frac{4\zeta(3)}{\pi(1-w^2)}$$

$$C_{-1} = \frac{(2\gamma + 6\log_e 2)(3w^8 - 60w^6 - 270w^4 - 60w^2 + 3)}{24\pi(1-w^2)^5}$$

$$- \frac{9w^8 - 228w^6 - 1354w^4 - 228w^2 + 9}{24\pi(1-w^2)^5}$$

$$+ \frac{768(w^5 + w^3)}{24\pi(1-w^2)^5} \log_e \left(\frac{1+w}{1-w} \right)$$

$$C_0 = - \frac{24(w^8 + 3w^6 + w^4)}{(1-w^2)^7}$$

$$L_{-1} = \frac{w^8 - 20w^6 - 90w^4 - 20w^2 + 1}{4\pi(1-w^2)^5}$$

Diffraction effects at 1st order:

- Extended source
- Monochromatic or blackbody radiation

Bkg: AO 37, 6581 (1998);
 JOSA A 21, 1895 (2004)

Introduce:

$$\sigma = \frac{\min(R_s / d_s, R_d / d_d)}{\max(R_s / d_s, R_d / d_d)}$$

$$g(\sigma, x) = (1 + \sigma x)^{-1} \{ (1 - x^2) [(2 + \sigma x)^2 - \sigma^2] \}^{1/2}$$

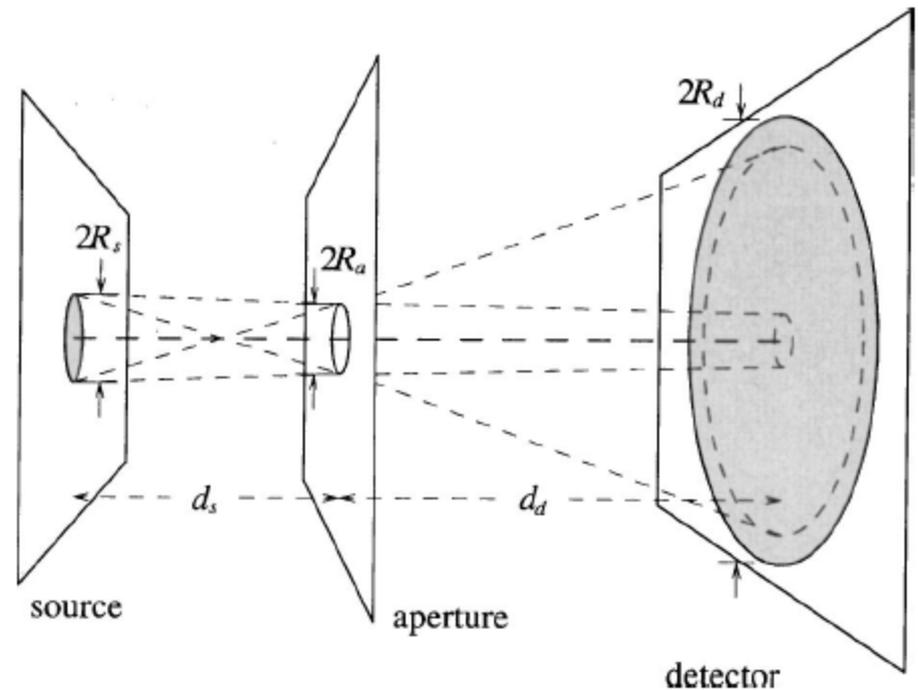
$$\alpha(\sigma, x) = 2\pi R_a (1 + \sigma x) \max(R_s / d_s, R_d / d_d)$$

$$C = \pi R_a^2 [\min(R_s / d_s, R_d / d_d)]^2$$

Then

$$\Phi_\lambda(\lambda) = C \int_{-1}^{+1} dx g(\sigma, x) L(u, \alpha(\sigma, x) / \lambda) L_\lambda(\lambda)$$

$$\Phi = C \int_{-1}^{+1} dx g(\sigma, x) \int_0^\infty d\lambda L(u, \alpha(\sigma, x) / \lambda) L_\lambda(\lambda)$$



Amenable to efficient
 Numerical integration

Separating diffraction effects because of 1 element (1st-order),
 2 elements (2nd-order), etc.:

Bkg: JMO 54, 515 (2007)

$$\begin{aligned}
 u(\mathbf{Q}) &= \frac{U_0}{(i\lambda)^N} \int_{A_1} d\mathbf{x}_1 \dots \int_{A_k} d\mathbf{x}_k \dots \int_{A_N} d\mathbf{x}_N F(\mathbf{P}, \mathbf{Q}, \{\mathbf{x}_k\}) \\
 &= \frac{U_0}{(i\lambda)^N} \left(\underbrace{\int_{A_1} + \int_{A'_1} - \int_{A''_1}} \right) d\mathbf{x}_1 \dots \left(\underbrace{\int_{A_k} + \int_{A'_k} - \int_{A''_k}} \right) d\mathbf{x}_k \dots \left(\underbrace{\int_{A_N} + \int_{A'_N} - \int_{A''_N}} \right) d\mathbf{x}_N F(\mathbf{P}, \mathbf{Q}, \{\mathbf{x}_k\})
 \end{aligned}$$

Integration over entire plane
 → Free-space propagation through
 plane of an element
 (but with focusing effects included)

Small effect, *might* be written as 1-d integral
 around optical element perimeter



Separating diffraction effects because of 1 element (1st-order),
2 elements (2nd-order), etc.:

$$\begin{aligned}
 u(\mathbf{Q}) &= \frac{U_0}{(i\lambda)^N} \int_{A_1} d\mathbf{x}_1 \dots \int_{A_k} d\mathbf{x}_k \dots \int_{A_N} d\mathbf{x}_N F(\mathbf{P}, \mathbf{Q}, \{\mathbf{x}_k\}) \\
 &= \frac{U_0}{(i\lambda)^N} \left(\underbrace{\int_{A_1} + \int_{A'_1}}_{\text{blue}} - \underbrace{\int_{A'_1}}_{\text{red}} \right) d\mathbf{x}_1 \dots \left(\underbrace{\int_{A_k} + \int_{A'_k}}_{\text{blue}} - \underbrace{\int_{A'_k}}_{\text{red}} \right) d\mathbf{x}_k \dots \left(\underbrace{\int_{A_N} + \int_{A'_N}}_{\text{blue}} - \underbrace{\int_{A'_N}}_{\text{red}} \right) d\mathbf{x}_N F(\mathbf{P}, \mathbf{Q}, \{\mathbf{x}_k\})
 \end{aligned}$$

Introduce propagator G' (which may including focusing effects) and reorganize above, according to number of **primed regions** versus **whole planes** sampled in each of 2^N terms:

$$\begin{aligned}
 u(\mathbf{Q}) &= U_0 G'(\mathbf{P}, \mathbf{Q}) \\
 &\quad - \frac{U_0}{i\lambda} \sum_k \int_{A'_k} d\mathbf{x}_k G'(\mathbf{P}, \mathbf{x}_k) G'(\mathbf{x}_k, \mathbf{Q}) \\
 &\quad + \frac{U_0}{(i\lambda)^2} \sum_{k < N} \sum_{k' > k} \int_{A'_k} d\mathbf{x}_k \int_{A'_{k'}} d\mathbf{x}_{k'} G'(\mathbf{P}, \mathbf{x}_k) G'(\mathbf{x}_k, \mathbf{x}_{k'}) G'(\mathbf{x}_{k'}, \mathbf{Q}) \\
 &\quad - \dots
 \end{aligned}$$

Initial terms=easy to calculate; successive terms=more difficult,
but vanish more rapidly at small wavelength → a useful expansion

Separating diffraction effects because of 1 element (1st-order),
2 elements (2nd-order), etc.:

$$\begin{aligned}
 u(\mathbf{Q}) &= U_0 G'(\mathbf{P}, \mathbf{Q}) \\
 &\quad - \frac{U_0}{i\lambda} \sum_k \int_{A'_k} d\mathbf{x}_k G'(\mathbf{P}, \mathbf{x}_k) G'(\mathbf{x}_k, \mathbf{Q}) \\
 &\quad + \frac{U_0}{(i\lambda)^2} \sum_{k < N} \sum_{k' > k} \int_{A'_k} d\mathbf{x}_k \int_{A'_{k'}} d\mathbf{x}_{k'} G'(\mathbf{P}, \mathbf{x}_k) G'(\mathbf{x}_k, \mathbf{x}_{k'}) G'(\mathbf{x}_{k'}, \mathbf{Q}) \\
 &\quad - \dots
 \end{aligned}$$

This suggests a shorthand:

$$u(\mathbf{Q}) = u^{(0)}(\mathbf{P}, \mathbf{Q}) + \sum_k u_k^{(1)}(\mathbf{P}, \mathbf{Q}) + \sum_{k < N} \sum_{k' > k} u_{k,k'}^{(2)}(\mathbf{P}, \mathbf{Q}) + \dots$$

Expressible in path-length distributions f , aiding insight & analysis:

$$u_X^{(p)}(\mathbf{Q}) = \int_{-\infty}^{+\infty} dl e^{iql} f_X^{(p)}(\mathbf{P}, \mathbf{Q}; l)$$

A lot can be known about moments of the f functions.

Spectral and thermal aspects of diffraction:

Note:

$$\int_0^{\infty} d\lambda L_{\lambda}(\lambda) \{ [u_X^{(p)}(\mathbf{Q})]^* u_Y^{(q)}(\mathbf{Q}) + u_X^{(p)}(\mathbf{Q}) [u_Y^{(q)}(\mathbf{Q})]^* \}$$

$$= 2 \int_0^{\infty} d\lambda L_{\lambda}(\lambda) \int_{-\infty}^{+\infty} dl \int_{-\infty}^{+\infty} dl' \cos[q(l-l')] f_X^{(p)}(\mathbf{P}, \mathbf{Q}; l) f_Y^{(q)}(\mathbf{P}, \mathbf{Q}; l')$$

Convolutions of path-length distributions weighted by source spectral radiance, $L_{\lambda}(\lambda)$.

For a thermal source, $L_{\lambda}(\lambda)$ related to:

$$\beta = \frac{c_2}{2\pi T}$$

$$2 \int_0^{\infty} dq q^3 \cos(ql) (e^{\beta q} - 1)^{-1} = 6S(\beta, l)$$

$$S(\beta, l) = \sum_{n=1}^{\infty} [(n\beta + il)^{-4} + (n\beta - il)^{-4}]$$

At high T , behavior near $l=l'$ dictates any series expansion of diffraction effects in $1/T$:

$$I(\nu) = \int_0^{\infty} dl l^{\nu} S(\beta, l) = -\frac{\pi\nu(\nu-1)(\nu-2)\zeta(3-\nu)}{6\cos(\pi\nu/2)\beta^{3-\nu}}$$

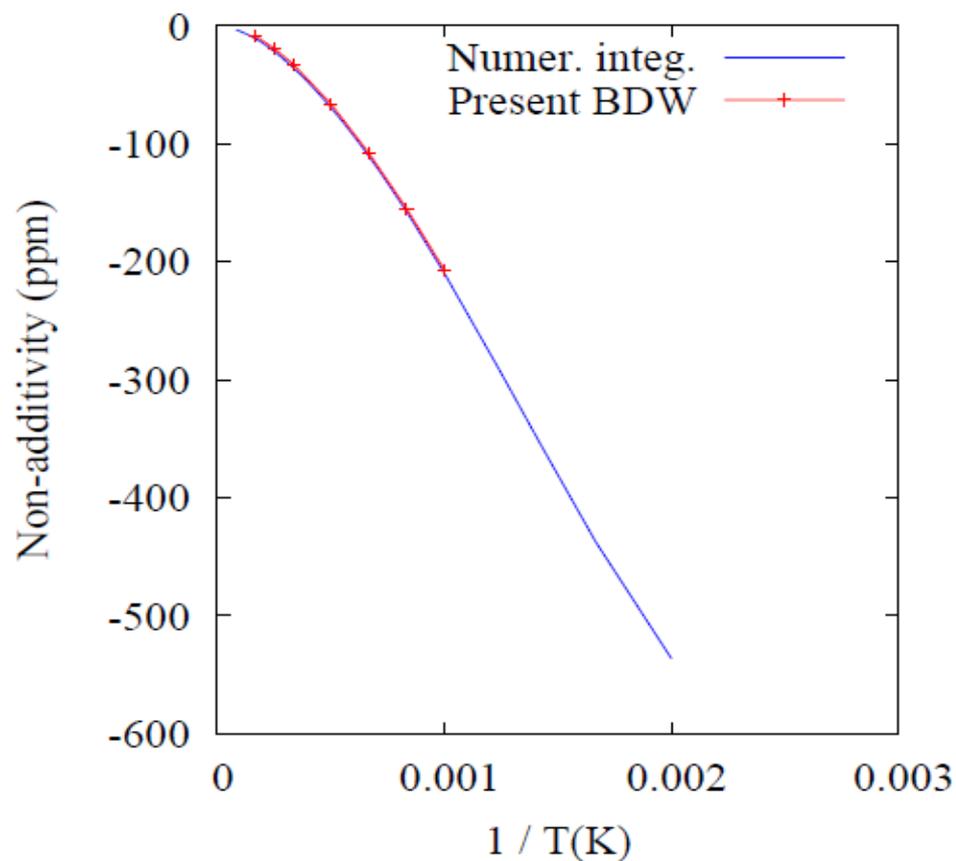
$$I(0) = 0$$

$$I(1) = -\frac{\zeta(2)}{3\beta^2}$$

$$I(2) = -\frac{\pi}{3\beta}$$

PRACTICAL CASE → Non-additivity of diffraction effects in ACRIM III:

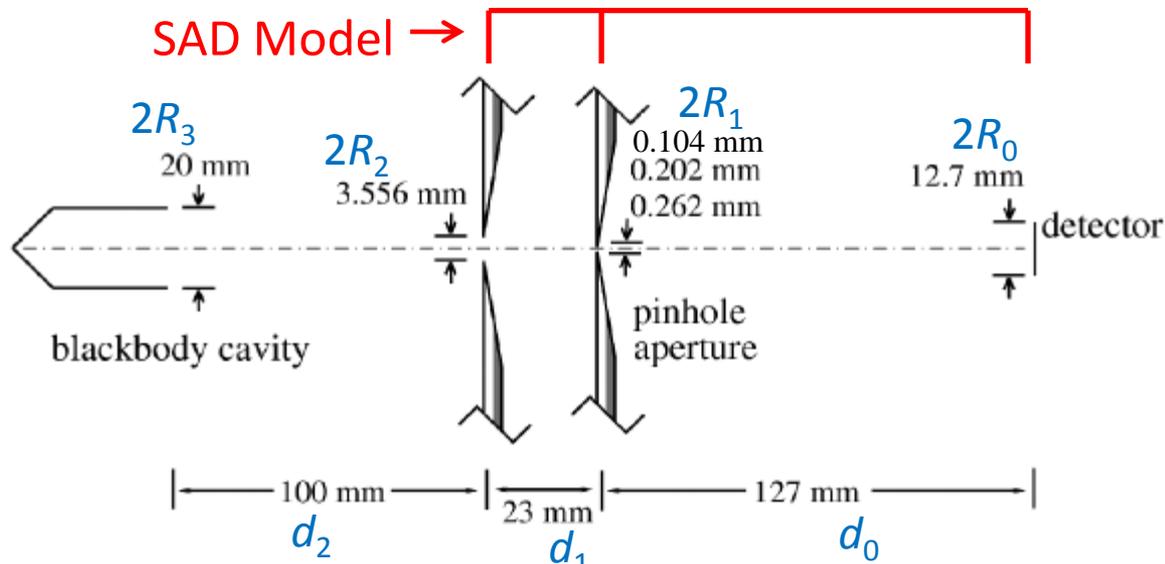
- 2 apertures:
 - 6.6548 mm radius, 151.8666 mm from cavity entrance
 - 5.1816 mm radius, 67.2084 mm from cavity entrance
- About 1600 ppm extra power because of diffraction (5900K sun)
- 3.9878 mm radius cavity entrance
- Results obtained numerically (full calculation) and using the higher-order BDW approach



PRACTICAL CASE →

2nd-order loss due to separation between blackbody & 3.556 mm aperture.

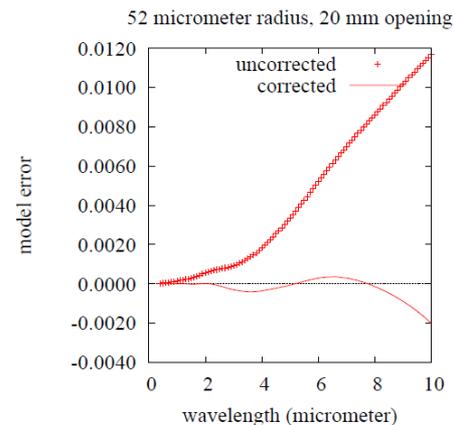
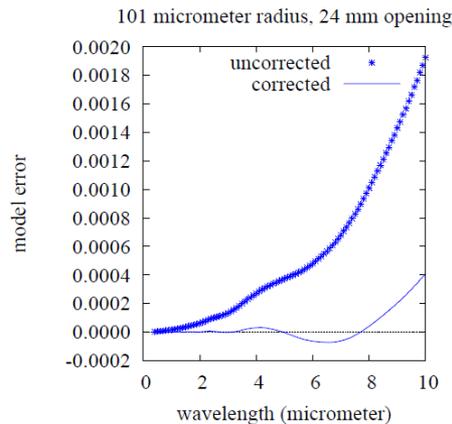
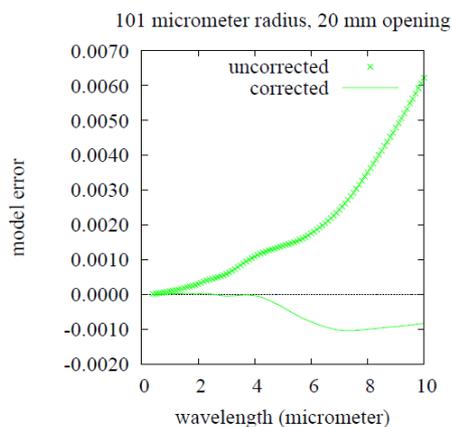
Blackbody fills pinhole's FOV through aperture, but only barely.



Approximate loss (valid at small wavelength, with BB amply overfilling pinhole's FOV):

$$\Delta \approx \left(\frac{\lambda d_1}{\pi^2 R_1 R_2} \right) \left(\frac{\lambda d_2}{\pi^2 R_2 R_3 \{1 - [(d_1 + d_2) R_2 / d_1]^2 / R_3^2\}} \right) \cdot \frac{1}{2} \cdot F \left(\frac{3}{2}, \frac{3}{2}; 2; \left(\frac{R_0 / d_0}{R_2 / d_1} \right)^2 \right)$$

Error in model results before (points) and after (lines) correcting for above loss:



PRACTICAL CASE → Blackbody Calibration Scenario

- Blackbody, 4 mm radius opening, 30 mm from 0.075 mm radius pinhole aperture
- Active-cavity radiometer (ACR) 1116.56 mm from pinhole, 14.97 mm radius
- 15.835 mm radius stray-light-reducing baffle 155.58 mm upstream from ACR

- BB-pinhole-ACR combination alone: multiplicative diffraction factor, F_1
- Pinhole-baffle-ACR combination alone: multiplicative diffraction factor, F_2

Diffraction factor has correction (Δ) because of non-additivity: $F = 1 + (F_2 - 1) + (F_1 - 1) + \Delta$

Approximate formula for Δ :

Baffle illuminated:

$$\Delta \approx (F_1 - 1)(F_2 - 1) \cdot F \left(\frac{3}{2}, \frac{1}{2}; 1; \left(\frac{R_2 / d_1}{R_0 / d_0} \right)^2 \right)$$

Baffle not illuminated:

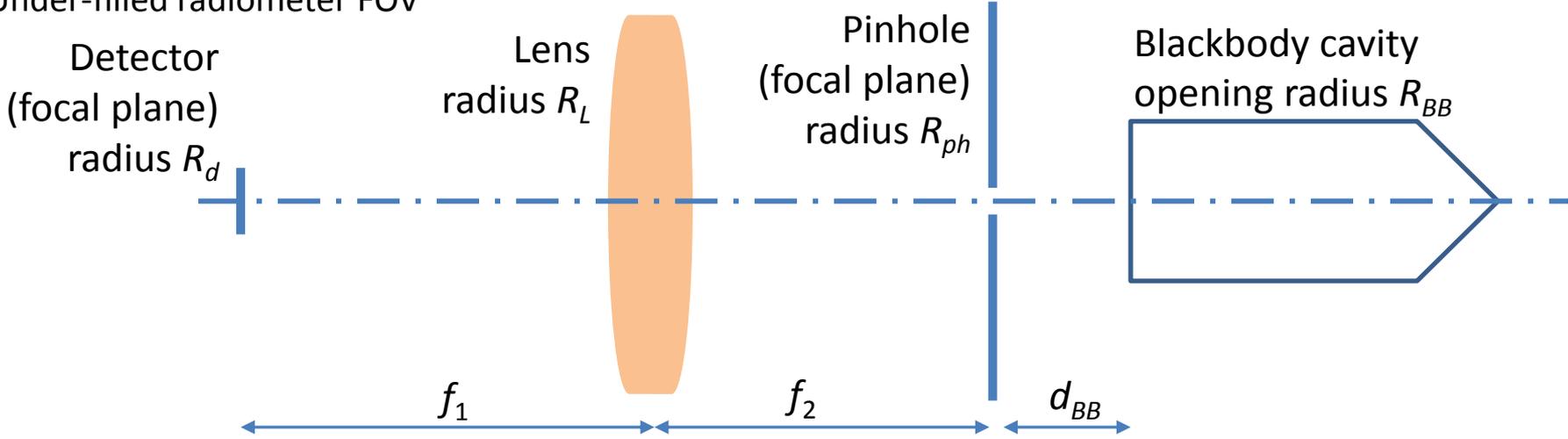
$$\Delta \approx -\frac{1}{2} \cdot \left(\frac{R_0 / d_0}{R_2 / d_1} \right)^3 (F_1 - 1)(F_2 - 1) F \left(\frac{3}{2}, \frac{3}{2}; 2; \left(\frac{R_0 / d_0}{R_2 / d_1} \right)^2 \right)$$

Sample results:

λ (mm)	$F_2 - 1$	F_1	F (numer.)	Δ (numer.)	Δ (formula)
0.0060	0.0010	0.9384	0.9393	-0.0001	-0.0001
0.0080	0.0026	0.9147	0.9171	-0.0002	-0.0002
0.0100	0.0031	0.9045	0.9073	-0.0003	-0.0003
0.0200	-0.0003	0.8242	0.8239	0.0000	0.0001
0.0300	0.0128	0.6453	0.6535	-0.0046	-0.0046

PRACTICAL CASE → Collimator + Imaging Radiometer Example

- Over-filled radiometer pupil
- Under-filled radiometer FOV



Call area of detector, lens, pinhole and BB opening A, B, C, D.

Denote remainder area of their planes by A', B', C', D'.

T(XY) relates:

power incident on area X
radiance on area Y.

$$T(BC) = T(AD) + T(AD') + T(A'D) + T(A'D')$$

$$T(AD) = T(BC) - T(AD') - T(A'D) - T(A'D')$$

$$= T(BC) + \underline{T(A'D')} - [T(AD') + \underline{T(A'D')}] - [T(A'D) - T(A'D')]$$

$$= T(BC) - T(BD') - T(A'C) + T(A'D')$$

↑
trivial

↑
1st-order

↑
2nd-order & small

Effective formula: $\frac{T(A'D')}{T(BC)} \approx \left(\frac{\lambda f_1}{\pi^2 R_d R_L} \right) \left(\frac{\lambda d_{BB}}{\pi^2 R_{ph} R_{BB}} \right)$

Conclusions

- One can itemize diffraction effects in a way that separates effects order by order.
 - *This can give physical/mathematical insight into the reason for various behaviors.*
- Useful approximations can be found that work to varying degrees.
 - *Further work remains to fully assess their utility.*
- In the few cases studied to date, it appears that, for systems other than the source-aperture-detector cases, a “clean” expansion of effects versus wavelength or temperature is not assured.